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Bib Data Sheet

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APPLICANTS

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\*\* CONTINUING DATA \*\*\*\*\* *None*

\*\* FOREIGN APPLICATIONS \*\*\*\*\*  
 JAPAN 2002-240675 08/21/2002 *OK JL*

IF REQUIRED, FOREIGN FILING LICENSE GRANTED  
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|   |                                   |                         |                       |                            |
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| Foreign Priority claimed<br><input checked="" type="checkbox"/> yes <input type="checkbox"/> no   | STATE OR<br>COUNTRY<br>JAPAN      | SHEETS<br>DRAWING<br>11 | TOTAL<br>CLAIMS<br>48 | INDEPENDENT<br>CLAIMS<br>5 |
| 35 USC 119 (a-d) conditions met<br><input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance | EXAMINER'S SIGNATURE<br><i>JL</i> | INITIALS<br><i>JL</i>   |                       |                            |

Verified and Acknowledged

ADDRESS  
 22428  
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TITLE  
 Probe testing method and apparatus for determining acceptable/defective end shape of contact probe through image analysis

|                                    |   |   |
|------------------------------------|---|---|
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